

N-Channel Enhancement Mode Power MOSFET

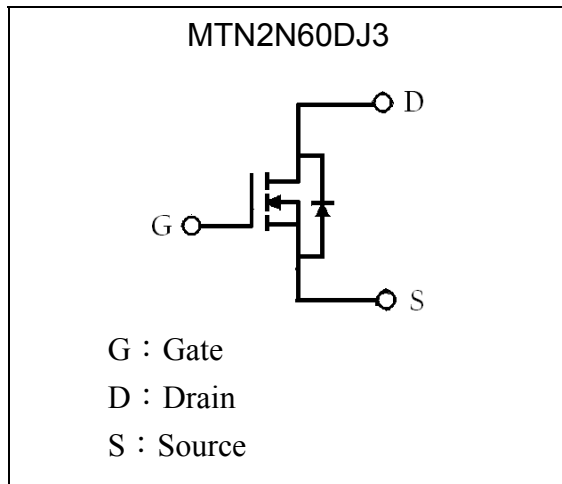
MTN2N60DJ3

BV_{DSS}	600V
$I_D @ V_{GS}=10V, T_C=25^\circ C$	2A
$R_{DS(on)(TYP)} @ V_{GS}=10V, I_D=1A$	3.7Ω

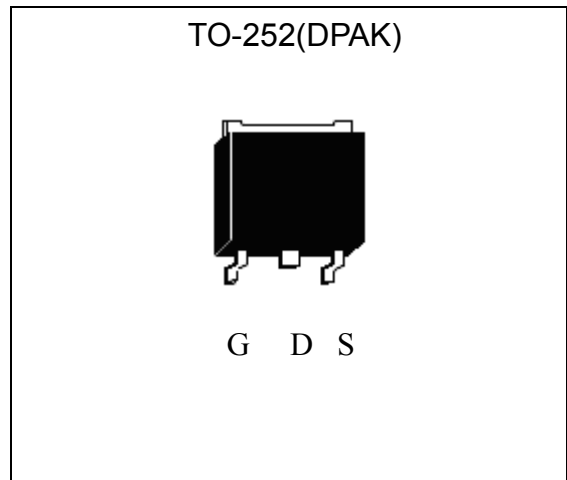
Features

- Low On Resistance
- Simple Drive Requirement
- Low Gate Charge
- Fast Switching Characteristic
- RoHS compliant package

Symbol

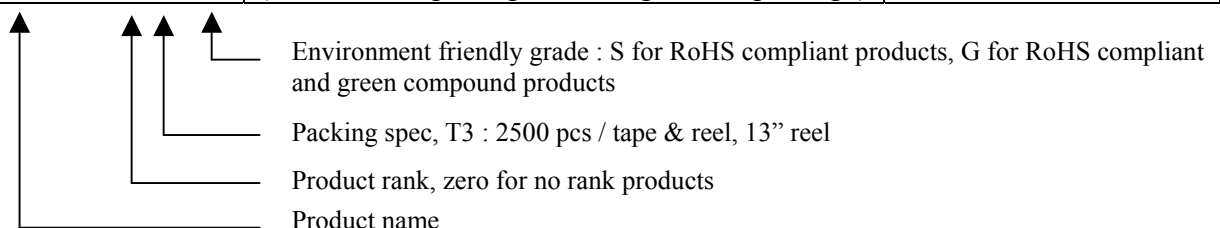


Outline



Ordering Information

Device	Package	Shipping
MTN2N60DJ3-0-T3-G	TO-252 (Pb-free lead plating and halogen-free package)	2500 pcs / Tape & Reel



**Absolute Maximum Ratings** ($T_C=25^\circ\text{C}$)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	V_{DS}	600	V
Gate-Source Voltage	V_{GS}	± 30	
Continuous Drain Current @ $V_{GS}=10\text{V}$, $T_C=25^\circ\text{C}$	I_D	2	A
Continuous Drain Current @ $V_{GS}=10\text{V}$, $T_C=100^\circ\text{C}$		1.3	
Pulsed Drain Current (Note 1)	I_{DM}	8	
Single Pulse Avalanche Current (Note 1)	I_{AS}	2	
Single Pulse Avalanche Energy @ $L=80\text{mH}$, $I_D=2\text{Amps}$, $V_{DD}=50\text{V}$ (Note 2)	E_{AS}	160	mJ
Repetitive Avalanche Energy (Note 1)	E_{AR}	4.4	
Maximum Temperature for Soldering @ Lead at 0.125 in(0.318mm) from case for 10 seconds	T_L	300	$^\circ\text{C}$
Total Power Dissipation ($T_A=25^\circ\text{C}$)	P_D	1.14	W
Total Power Dissipation ($T_C=25^\circ\text{C}$)		44	
Linear Derating Factor		0.35	$\text{W}/^\circ\text{C}$
Operating Junction and Storage Temperature	T_j, T_{stg}	-55~+150	$^\circ\text{C}$

Note : 1.Pulse width limited by maximum junction temperature.

2.100% tested by conditions of $L=40\text{mH}$, $I_{AS}=2\text{A}$, $V_{GS}=10\text{V}$, $V_{DD}=50\text{V}$.

Thermal Data

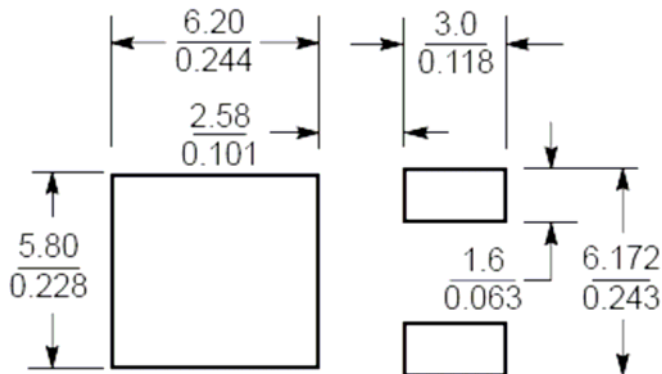
Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	$R_{\theta JC}$	2.87	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction-to-ambient, max	$R_{\theta JA}$	50 (Note)	
Thermal Resistance, Junction-to-ambient, max		110	

Note : When the device is mounted on 1 in²FR-4 board with 2 oz. copper, in a still air environment with $T_A=25^\circ\text{C}$.

Characteristics (Tc=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	600	-	-	V	V _{GS} =0V, I _D =250μA
ΔBV _{DSS} /ΔT _j	-	0.6	-	V/°C	Reference to 25°C, I _D =250μA
V _{GS(th)}	2.0	-	4.0	V	V _{DS} = V _{GS} , I _D =250μA
*G _{FS}	-	2.3	-	S	V _{DS} =15V, I _D =1A
I _{GSS}	-	-	±100	nA	V _{GS} =±30V
I _{DSS}	-	-	1	μA	V _{DS} =600V, V _{GS} =0V
	-	-	10		V _{DS} =480V, V _{GS} =0V, T _j =125°C
*R _{DS(ON)}	-	3.7	4.7	Ω	V _{GS} =10V, I _D =1A
Dynamic					
*Q _g	-	9.2	13.8	nC	I _D =2A, V _{DD} =480V, V _{GS} =10V
*Q _{gs}	-	2.2	-		
*Q _{gd}	-	3.6	-		
*t _{d(ON)}	-	7.2	10.8	ns	V _{DD} =300V, I _D =2A, V _{GS} =10V, R _G =25 Ω
*t _r	-	8	12		
*t _{d(OFF)}	-	17	25.5		
*t _f	-	9.8	14.7		
C _{iss}	-	274	411	pF	V _{GS} =0V, V _{DS} =25V, f=1MHz
C _{oss}	-	36	54		
C _{rss}	-	10	15		
Source-Drain Diode					
*V _{SD}	-	-	1.5	V	I _S =2A, V _{GS} =0V
*I _S	-	-	2	A	
*I _{SM}	-	-	8		
*t _{rr}	-	422	-	ns	V _{GS} =0V, I _F =2A, dI _F /dt=100A/μs
*Q _{rr}	-	850	-	nC	

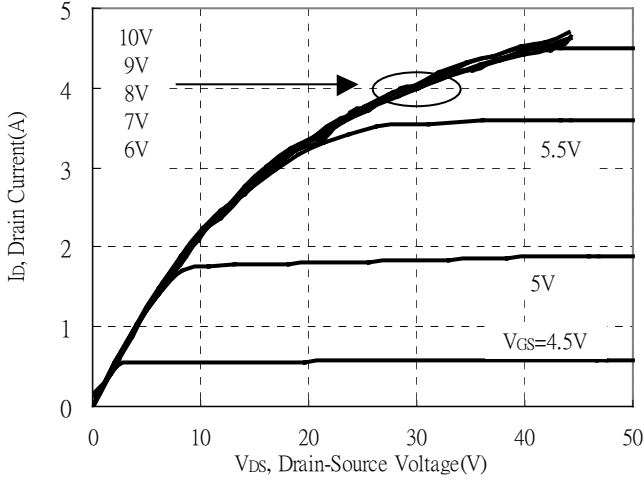
*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

Recommended soldering footprint

 Unit ($\frac{\text{mm}}{\text{inch}}$)

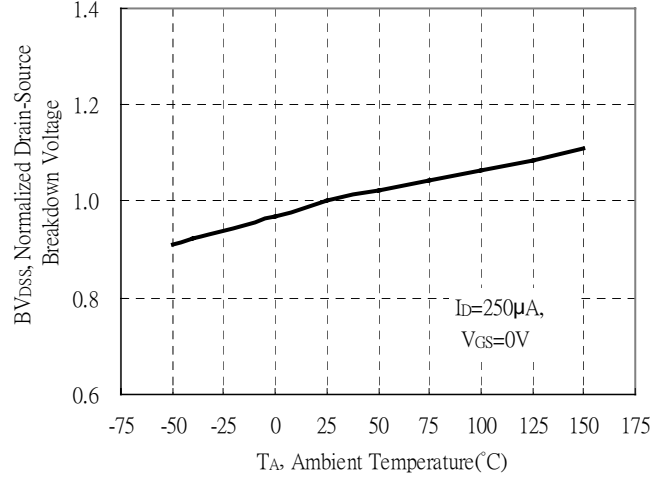


Typical Characteristics

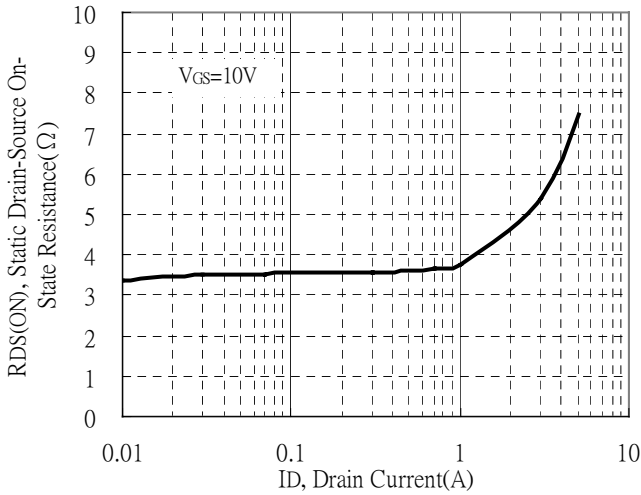
Typical Output Characteristics



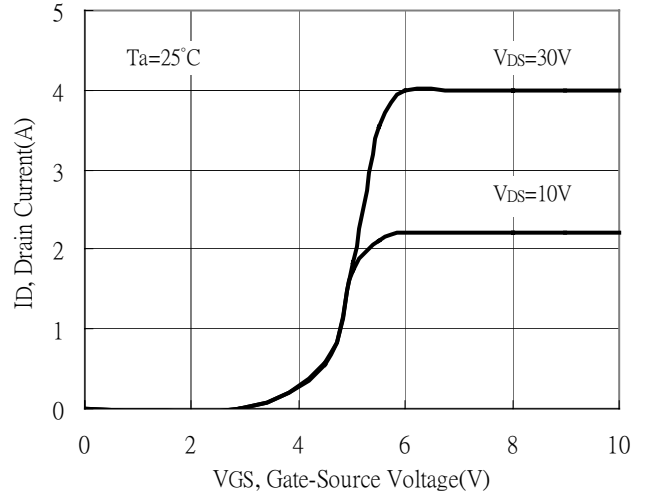
Brekdown Voltage vs Ambient Temperature



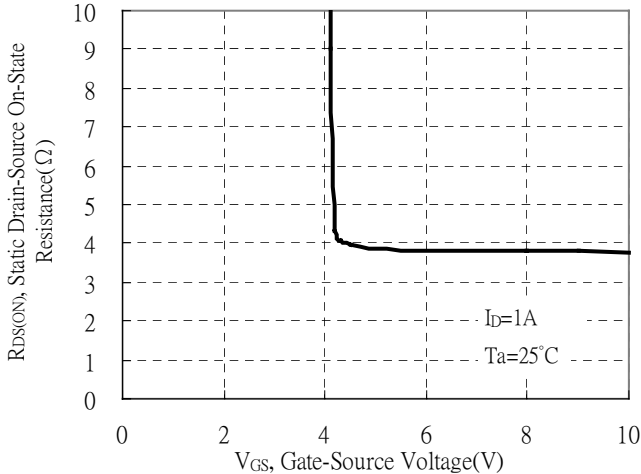
Static Drain-Source On-State resistance vs Drain Current



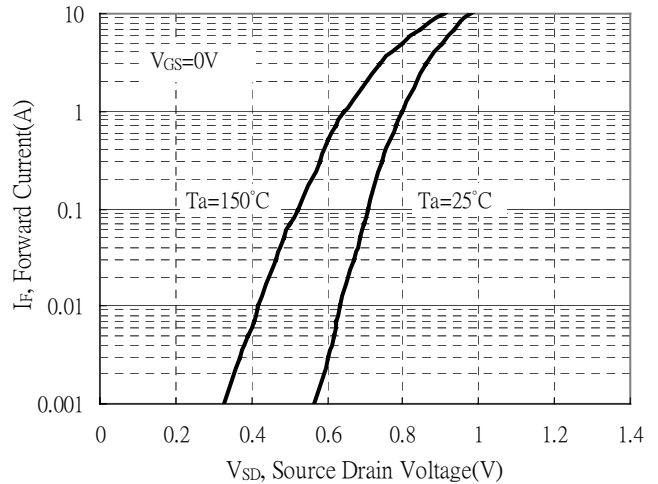
Drain Current vs Gate-Source Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

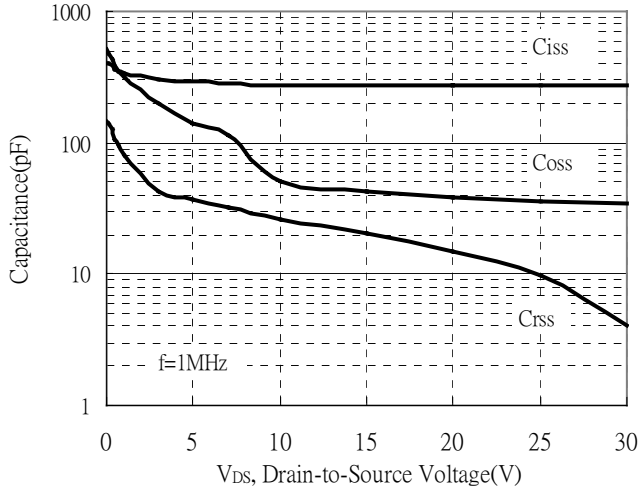


Forward Drain Current vs Source-Drain Voltage

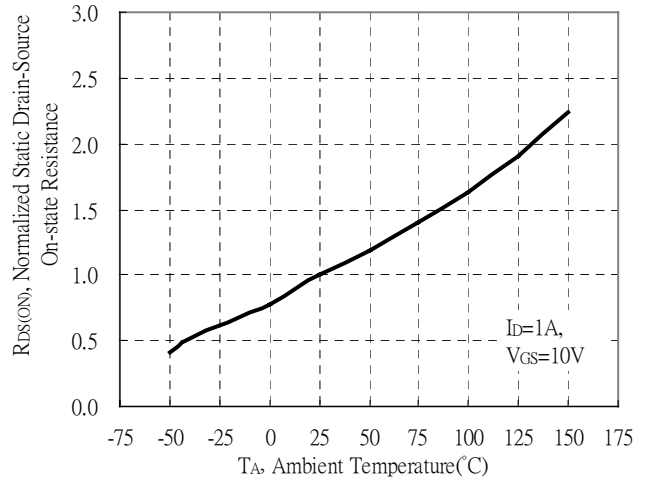


Typical Characteristics(Cont.)

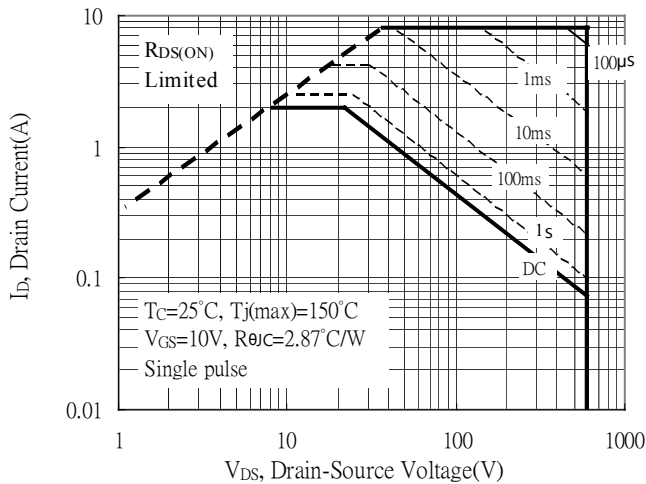
Capacitance vs Reverse Voltage



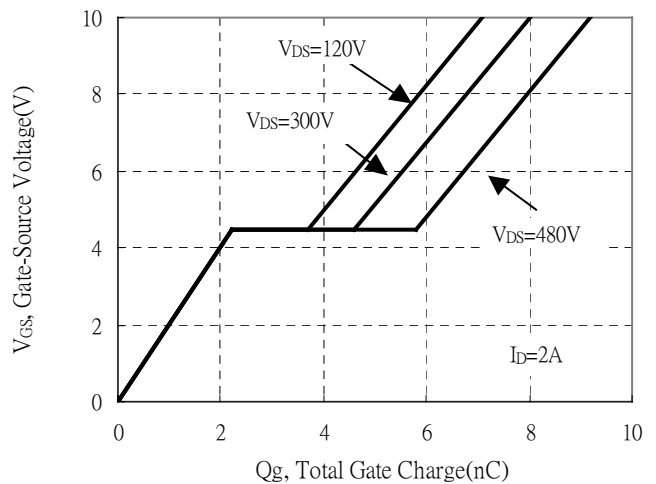
Static Drain-Source On-resistance vs Ambient Temperature



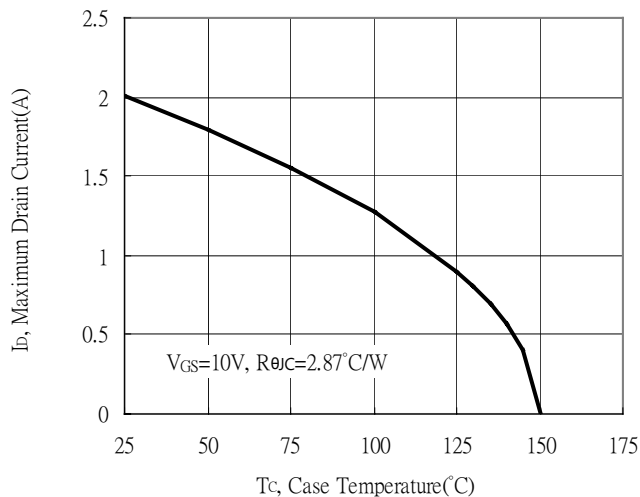
Maximum Safe Operating Area



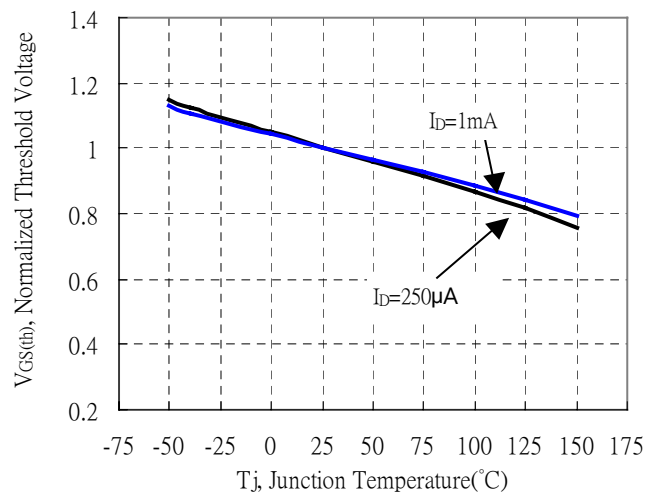
Gate Charge Characteristics



Maximum Drain Current vs Case Temperature



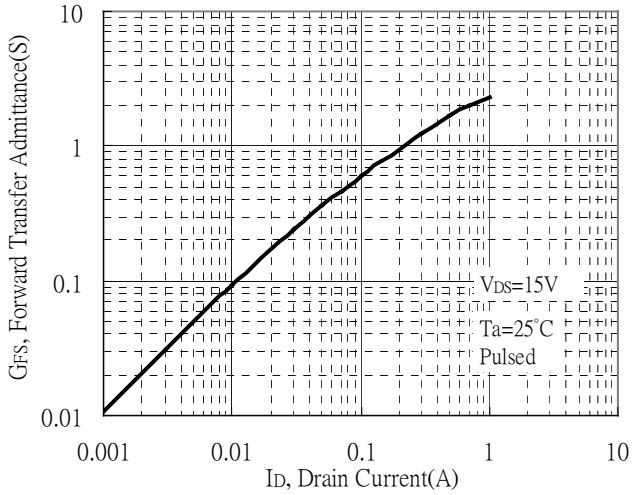
Threshold Voltage vs Junction Temperature



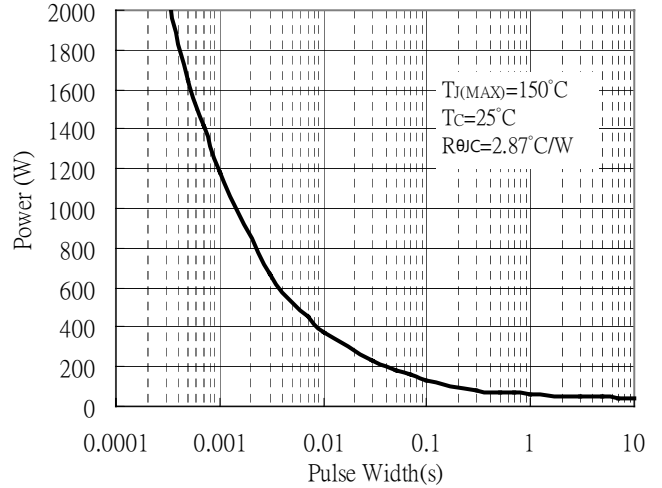


Typical Characteristics(Cont.)

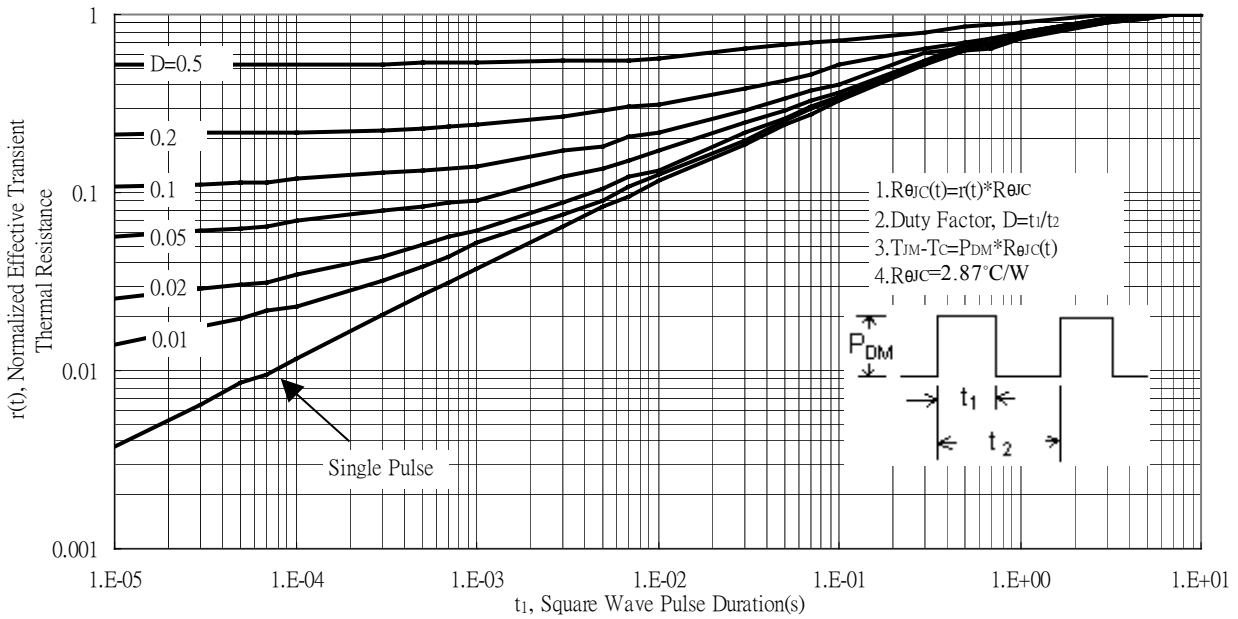
Forward Transfer Admittance vs Drain Current



Single Pulse Power Rating, Junction to Case



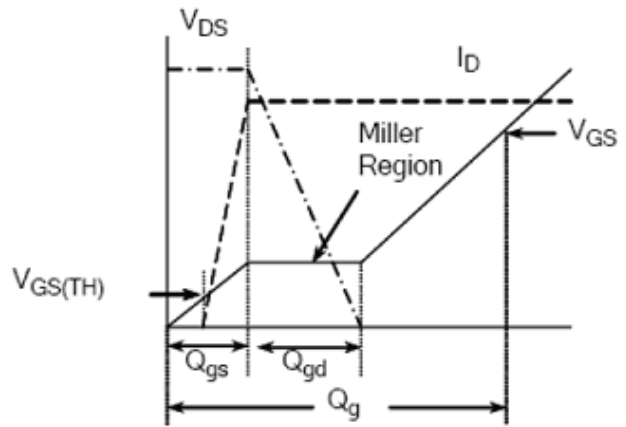
Transient Thermal Response Curves



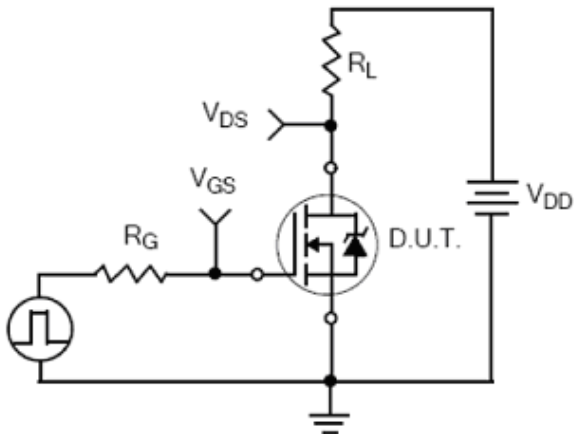
Test Circuits and Waveforms



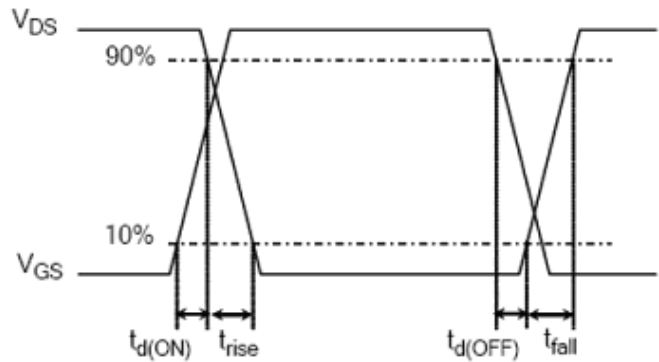
Gate Charge Test Circuit



Gate Charge Waveform



Resistive Switching Test Circuit



Resistive Switching Waveforms

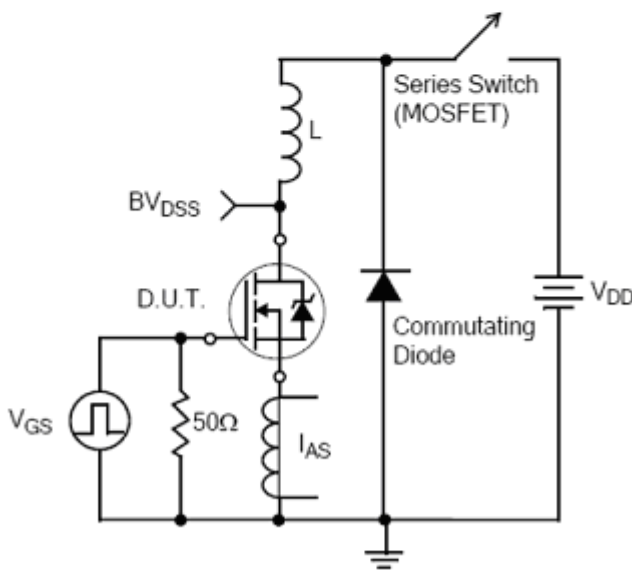
Test Circuits and Waveforms(Cont.)



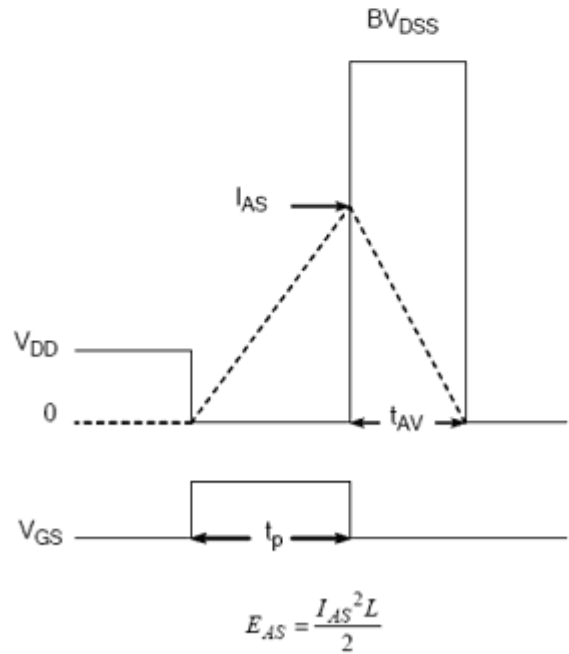
Diode Reverse Recovery Test Circuit



Diode Reverse Recovery Waveform



Unclamped Inductive Switching Test Circuit

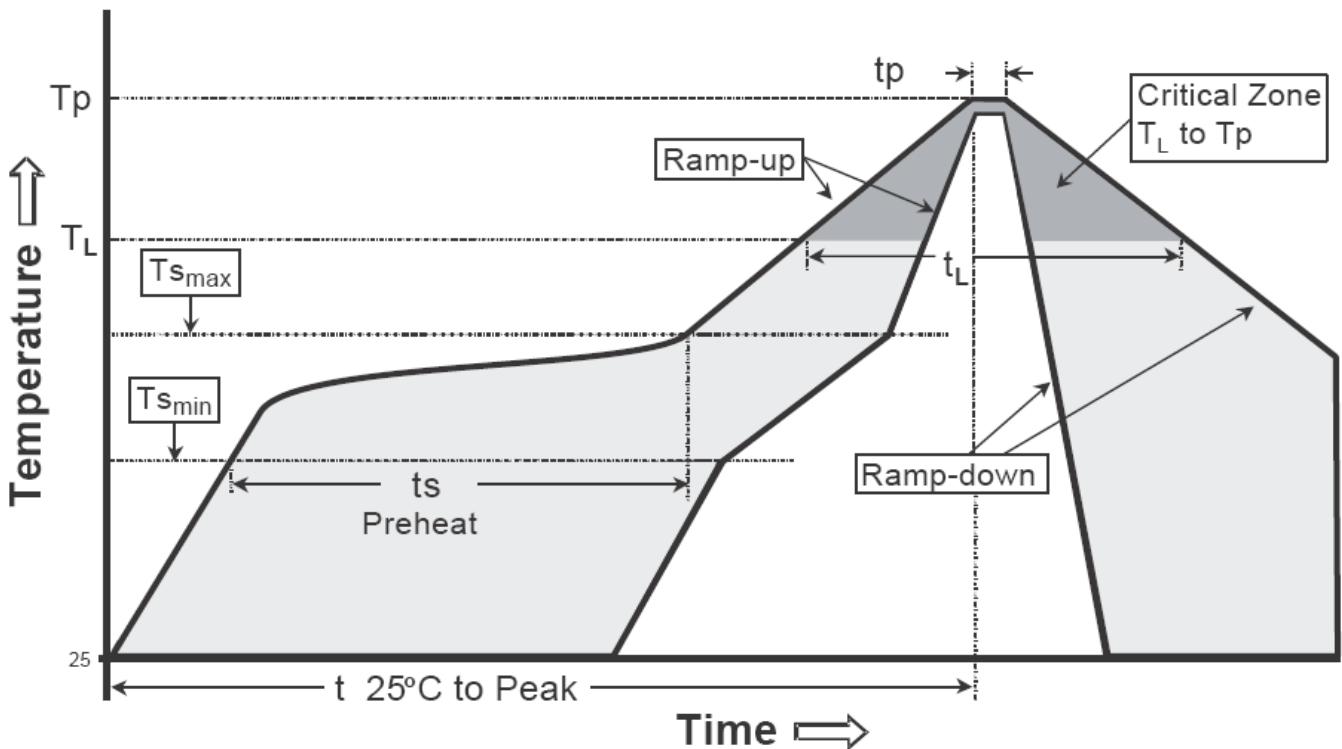


Unclamped Inductive Switching Waveforms

Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

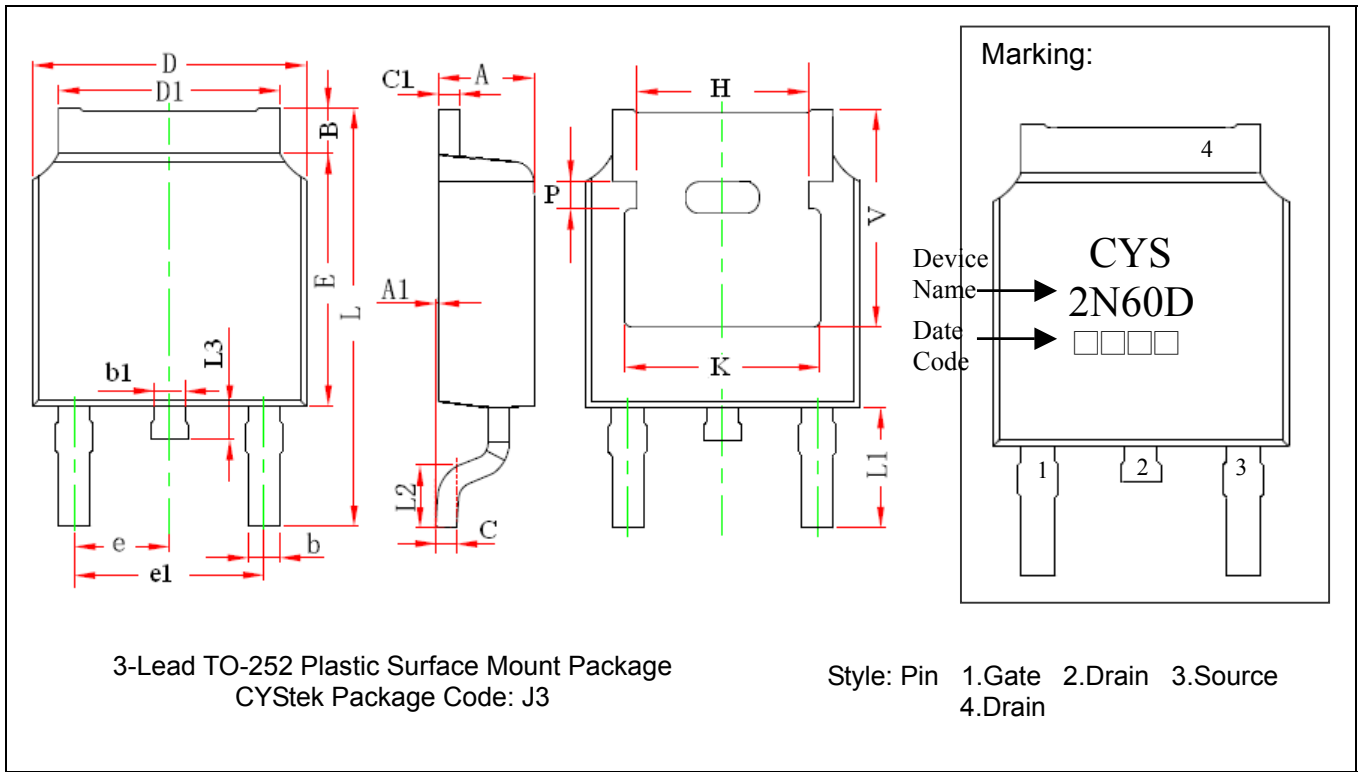
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T _{smax} to T _p)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T _{s min})	100°C	150°C
-Temperature Max(T _{s max})	150°C	200°C
-Time(t _{s min} to t _{s max})	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T _L)	183°C	217°C
- Time (t _L)	60-150 seconds	60-150 seconds
Peak Temperature(T _P)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

TO-252 Dimension



DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.087	0.094	2.200	2.400	e	0.086	0.094	2.186	2.386
A1	0.000	0.005	0.000	0.127	e1	0.172	0.188	4.372	4.772
B	0.039	0.048	0.990	1.210	H	0.163	REF	4.140	REF
b	0.026	0.034	0.660	0.860	K	0.190	REF	4.830	REF
b1	0.026	0.034	0.660	0.860	L	0.386	0.409	9.800	10.400
C	0.018	0.023	0.460	0.580	L1	0.114	REF	2.900	REF
C1	0.018	0.023	0.460	0.580	L2	0.055	0.067	1.400	1.700
D	0.256	0.264	6.500	6.700	L3	0.024	0.039	0.600	1.000
D1	0.201	0.215	5.100	5.460	P	0.026	REF	0.650	REF
E	0.236	0.244	6.000	6.200	V	0.211	REF	5.350	REF

- Notes: 1.Controlling dimension: millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead : Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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